AM26C32C, AM26C32I, AM26C32Q . . . D, N, OR NS PACKAGE

SLLS104H - DECEMBER 1990 - REVISED FEBRUARY 2002

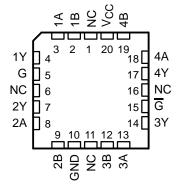
- Meets or Exceeds the Requirements of ANSI TIA/EIA-422-B, TIA/EIA-423-B, and ITU Recommendation V.10 and V.11
- Low Power, I<sub>CC</sub> = 10 mA Typ
- ±7-V Common-Mode Range With ±200-mV Sensitivity
- Input Hysteresis . . . 60 mV Typ
- t<sub>pd</sub> = 17 ns Typ
- Operates From a Single 5-V Supply
- 3-State Outputs
- Input Fail-Safe Circuitry
- Improved Replacements for AM26LS32
- Available in Q-Temp Automotive
  - High Reliability Automotive Applications
  - Configuration Control/Print Support
  - Qualification to Automotive Standards

#### description

The AM26C32 is a quadruple differential line receiver for balanced or unbalanced digital data transmission. The enable function is common to all four receivers and offers a choice of active-high or active-low input. The 3-state outputs permit connection directly to a bus-organized system. Fail-safe design specifies that if the inputs are open, the outputs are always high.

AM26C32M	AM26C32M J OR W PACKAGE								
	(ТС	P VIEW	)						
1B [	1	16	] V <sub>CC</sub>						
1A [	2	15	] 4B						
1Y [	3	14	] 4A						
G [	4	13	] 4Y						
2Y [	5	12	] G						
2A [	6	11	] 3Y						
2B [	7	10	] 3A						
GND [	8	9	] 3B						
I									

AM26C32M . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The AM26C32 devices are manufactured using a BiCMOS process, which is a combination of bipolar and CMOS transistors. This process provides the high voltage and current of bipolar with the low power of CMOS to reduce the power consumption to about one-fifth that of the standard AM26LS32, while maintaining ac and dc performance.

The AM26C32C is characterized for operation from 0°C to 70°C. The AM26C32I is characterized for operation from –40°C to 85°C. The AM26C32Q is characterized for operation from –40°C to 125°C. The AM26C32M is characterized for operation over the full military temperature range of –55°C to 125°C.



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## AM26C32 QUADRUPLE DIFFERENTIAL LINE RECEIVER

SLLS104H – DECEMBER 1990 – REVISED FEBRUARY 2002

AVAILABLE OPTIONS									
	PACKAGED DEVICES								
T <sub>A</sub> SMALL PLASTIC OUTLINE DIP (D, NS) (N)		CERAMIC CHIP CARRIER (FK)	CERAMIC DIP (J)	CERAMIC FLATPACK (W)					
0°C to 70°C	AM26C32CD AM26C32CNS	AM26C32CN —			—				
-40°C to 85°C	AM26C32ID AM26C32INS	AM26C32IN —	—	_	_				
–40°C to 125°C	AM26C32QD	AM26C32QN	_	_	—				
–55°C to 125°C	_	_	AM26C32MFK	AM26C32MJ	AM26C32MW				

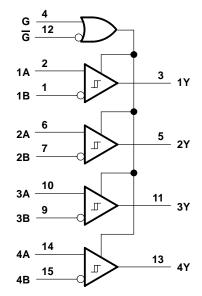
The D package is available taped and reeled. Add the suffix R to the device type (e.g., AM26C32CDR). The NS package is only available taped and reeled.

FUNCTION TABLE
(each receiver)

DIFFERENTIAL	ENA	BLES	OUTPUT		
INPUT	G	G	Y		
M SM	Н	Х	Н		
$V_{ID} \ge V_{IT+}$	Х	L	Н		
	Н	Х	?		
$V_{IT-} < V_{ID} < V_{IT+}$	Х	L	?		
	Н	Х	L		
V <sub>ID</sub> ≤ V <sub>IT</sub> _	Х	L	L		
Х	L	Н	Z		

H = high level, L = low level, X = irrelevant Z = high impedance (off), ? = indeterminate

### logic diagram (positive logic)

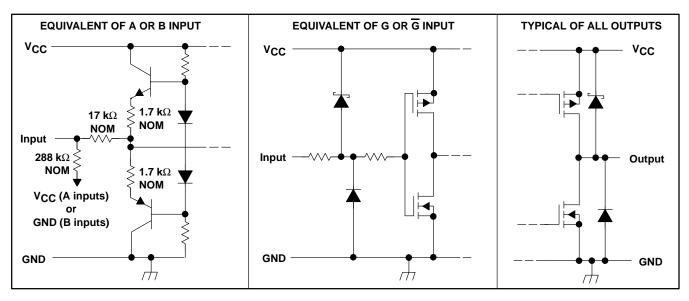


Pin numbers shown are for the D, J, N, NS, and W packages.



### AM26C32 QUADRUPLE DIFFERENTIAL LINE RECEIVER

SLLS104H - DECEMBER 1990 - REVISED FEBRUARY 2002



#### schematics

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage, V <sub>CC</sub> (see Note 1)	
Input voltage range, VI: A or B inputs	$\dots \dots \dots -11$ V to 14 V
G or $\overline{G}$ inputs	$\dots$ –0.5 V to V <sub>CC</sub> + 0.5 V
Differential input voltage range, V <sub>ID</sub>	–14 V to 14 V
Output voltage range, V <sub>O</sub>	$\dots$ –0.5 V to V <sub>CC</sub> + 0.5 V
Output current, I <sub>O</sub>	±25 mA
Package thermal impedance, $\theta_{JA}$ (see Notes 2 and 3): D package	73°C/W
N package	67°C/W
NS package	64°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>+</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential output voltage, V<sub>OD</sub>, are with respect to network GND. Currents into the device are positive and currents out of the device are negative.

- 2. Maximum power dissipation is a function of  $T_J(max)$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(max) T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.



SLLS104H - DECEMBER 1990 - REVISED FEBRUARY 2002

#### recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	V
VIH	High-level input voltage		2			V
VIL	Low-level input voltage				0.8	V
VIC	Common-mode input voltage				±7	V
ЮН	IOH High-level output current				-6	mA
IOL	Low-level output current				6	mA
	T <sub>A</sub> Operating free-air temperature	AM26C32C	0		70	
<b>Γ</b> .		AM26C32I	-40		85	°C
'A		AM26C32Q	-40		125	-0
	AM26C32N				125	

## electrical characteristics over recommended ranges of $V_{CC},\ V_{IC},$ and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST C	MIN	TYP†	MAX	UNIT	
\/	Differential input high-threshold voltage	$V_{O} = V_{OH}(min),$	$V_{IC} = -7 V \text{ to } 7 V$			0.2	V
VIT+	Differential input high-timeshold voltage	I <sub>OH</sub> = -440 μA	$V_{IC} = 0$ to 5.5 V			0.1	v
N/	Differential input low-threshold voltage	V <sub>O</sub> = 0.45 V,	$V_{IC} = -7 V \text{ to } 7 V$	-0.2‡			v
VIT-		$I_{OL} = 8 \text{ mA}$	$V_{IC} = 0$ to 5.5 V	-0.1‡			v
V <sub>hys</sub>	Hysteresis voltage (V <sub>IT+</sub> – V <sub>IT</sub> _)				60		mV
VIK	Enable input clamp voltage	V <sub>CC</sub> = 4.5 V,	lj = -18 mA			-1.5	V
∨он	High-level output voltage	V <sub>ID</sub> = 200 mV,	I <sub>OH</sub> = -6 mA	3.8			V
VOL	Low-level output voltage	$V_{ID} = -200 \text{ mV},$	I <sub>OL</sub> = 6 mA		0.2	0.3	V
loz	Off-state (high-impedance state) output current	$V_{O} = V_{CC}$ or GND			±0.5	±5	μA
		V <sub>I</sub> = 10 V,	Other input at 0 V			1.5	mA
tı -	Line input current	V <sub>I</sub> = -10 V,	Other input at 0 V			-2.5	IIIA
ЧΗ	High-level enable current	V <sub>I</sub> = 2.7 V				20	μA
١ <sub>IL</sub>	Low-level enable current	V <sub>I</sub> = 0.4 V				-100	μA
rj	Input resistance	One input to groun	d	12	17		kΩ
ICC	Supply current	V <sub>CC</sub> = 5.5 V			10	15	mA

<sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $V_{IC} = 0$ , and  $T_A = 25^{\circ}C$ . <sup>‡</sup> The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage.



SLLS104H - DECEMBER 1990 - REVISED FEBRUARY 2002

# switching characteristics over recommended ranges of operation conditions, $C_L = 50 \text{ pF}$ (unless otherwise noted)

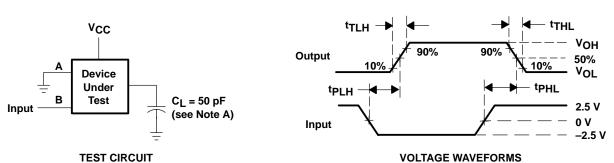
PARAMETER		TEST CONDITIONS	AM26C32C AM26C32I			AM26C32Q AM26C32M			UNIT
		CONDITIONS	MIN	түр†	MAX	MIN	TYP†	MAX	
tPLH	Propagation delay time, low- to high-level output	See Figure 1	9	17	27	9	17	27	ns
<sup>t</sup> PHL	Propagation delay time, high- to low-level output		9	17	27	9	17	27	ns
<sup>t</sup> TLH	Output transition time, low- to high-level output	See Figure 1		4	9		4	10	ns
<sup>t</sup> THL	Output transition time, high- to low-level output			4	9		4	9	ns
<sup>t</sup> PZH	Output enable time to high level	See Figure 2		13	22		13	22	ns
<sup>t</sup> PZL	Output enable time to low level			13	22		13	22	ns
<sup>t</sup> PHZ	Output disable time from high level	See Figure 2		13	22		13	26	ns
<sup>t</sup> PLZ	Output disable time from low level			13	22		13	25	ns

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.



## AM26C32 QUADRUPLE DIFFERENTIAL LINE RECEIVER

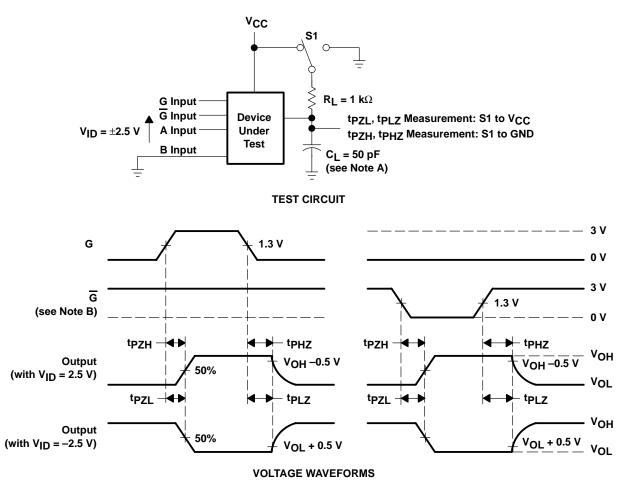
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#### PARAMETER MEASUREMENT INFORMATION

NOTE A: CL includes probe and jig capacitance.





NOTES: A. CL includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics: PRR = 1 MHz, duty cycle  $\leq$  50%, t<sub>f</sub> = t<sub>f</sub> = 6 ns.

Figure 2. Enable/Disable Time Test Circuit and Output Voltage Waveforms



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